

PT I
10/2/02
M.M.

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of :
HARUO FURUTA ET AL : GROUP ART UNIT: 2811
Serial No: 10/014,345 : EXAMINER: OWENS, D.
Filed: December 14, 2001 :
For: SEMICONDUCTOR DEVICE AND
MANUFACTURING METHOD THEREFOR

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POWER TO INSPECT AND MAKE COPIES

Assistant Commissioner for Patents
Washington, D.C. 20231

Dear Sir:

The undersigned hereby grants to Muralidhar Pai, or Khalid Quraishi the power to inspect the above-identified application and make copies thereof.

Respectfully submitted,

OBLON, SPIVAK, McCLELLAND,
MAIER & NEUSTADT, P.C.



Bradley D. Lytle
Registration No. 40,073



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